# 40V, 297A, 1.2mΩ N-channel Power SGT MOSFET

## JMSL0401PG

#### **Features**

- Excellent R<sub>DS(ON)</sub> and Low Gate Charge
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant

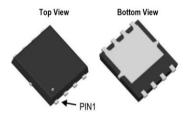
#### **Applications**

- Load Switch
- PWM Application
- Power Management

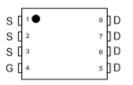
#### **Product Summary**

Parameters	Value	Unit
$V_{DSS}$	40	٧
$V_{GS(th)\_Typ}$	1.8	٧
$I_{D}(@V_{GS}=10V)$	297	Α
$R_{DS(ON)\_Typ}(@V_{GS}=10V$	0.8	mΩ
$R_{DS(ON)\_Typ}(@V_{GS}=4.5V$	1.2	mΩ

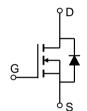




PDFN5x6-8L



**Pin Assignment** 



**Schematic Diagram** 

#### **Ordering Information**

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSL0401PG-13	SL0401P	1	Tape&Reel	PDFN5x6-8L	5000	50000

## Absolute Maximum Ratings (@ T<sub>C</sub> = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit	
$V_{DS}$	Drain-to-Source Voltage		40	V	
$V_{GS}$	Gate-to-Source Voltage		±20	V	
I.	Continuous Drain Current	$T_C = 25^{\circ}C$	297	Α	
I <sub>D</sub> Cont	Continuous Diain Current	$T_C = 100$ °C	188	Α	
I <sub>DM</sub>	Pulsed Drain Current (1)		Refer to Fig.4	Α	
E <sub>AS</sub>	Single Pulsed Avalanche Energy	, (2)	706	mJ	
$P_{D}$	Power Dissipation	$T_C = 25^{\circ}C$	156	W	
' D	r ower bissipation	$T_C = 100$ °C	63		
$T_{J}, T_{STG}$	Junction & Storage Temperature R	ange	-55 to 150	°C	

#### **Thermal Characteristics**

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient <sup>(3)</sup>	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.8	C/ VV



## **Electrical Characteristics** (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					l
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 32V, V_{GS} = 0V$	-	-	1.0	μА
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2	1.8	2.3	V
D	Static Drain-Source ON-Resistance <sup>(4)</sup>	$V_{GS} = 10V, I_D = 20A$	-	0.8	1.1	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source ON-Resistance	$V_{GS} = 4.5V, I_D = 15A$	-	1.2	1.7	mΩ
Dynami	ic Characteristics					
$R_{g}$	Gate Resistance	f = 1MHz	-	0.9	-	Ω
C <sub>iss</sub>	Input Capacitance		4720	6608	8920	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	1995	2793	3770	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11/11/12	167	234	316	pF
$Q_g$	Total Gate Charge		77	108	146	nC
$Q_{gs}$	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_D = 20A$	14	19	26	nC
$Q_{gd}$	Gate Drain("Miller") Charge	_ V <sub>DS</sub> = 20V, I <sub>D</sub> = 20A	16	22	29	nC
Switchi	ing Characteristics					
t <sub>d(on)</sub>	Turn-On DelayTime		-	17	-	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 20V$	-	33	-	ns
$t_{d(off)}$	Turn-Off DelayTime	$I_D = 20A, R_{GEN} = 3\Omega$	-	68	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	26	-	ns
<b>Body D</b>	iode Characteristics					
I <sub>S</sub>	Maximum Continuous Body Diode Forward	Current	-	-	297	Α
I <sub>SM</sub>	Maximum Pulsed Body Diode Forward Curr	ent	-	-	1188	А
V <sub>SD</sub>	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	I <sub>E</sub> = 20A, di/dt = 100A/us	45	63	85	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 20A$ , $ui/ui = 100A/uS$	-	93	-	nC

Notes:

<sup>1.</sup> Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

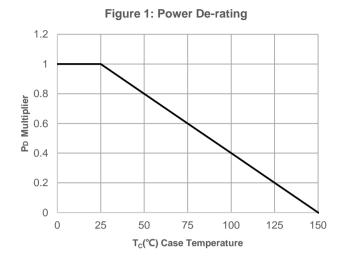
 $<sup>2.~</sup>E_{AS}~condition:~Starting~T_J=25C,~V_{DD}=15V,~V_{GS}=10V,~R_G=25ohm,~L=3mH,~I_{AS}=21.7A,~V_{DD}=0V~during~time~in~avalanche.$ 

<sup>3.</sup>  $R_{\theta JA}$  is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.

<sup>4.</sup> Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



# **Typical Performance Characteristics**



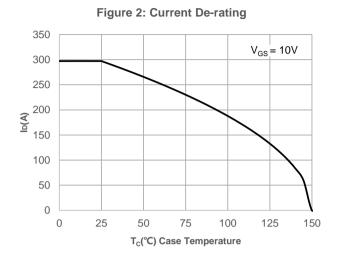
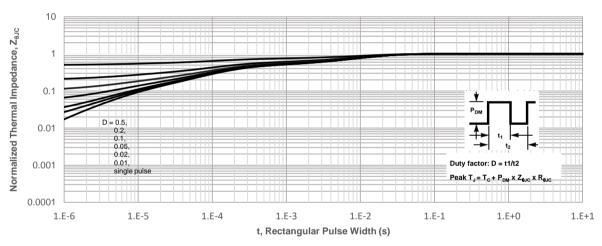
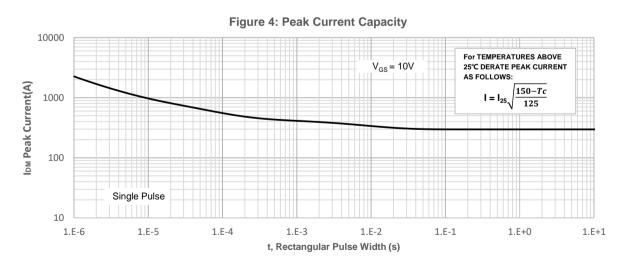


Figure 3: Normalized Maximum Transient Thermal Impedance







# **Typical Performance Characteristics**

Figure 5: Output Characteristics

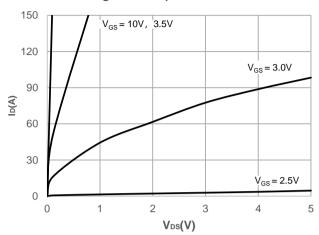


Figure 6: Typical Transfer Characteristics

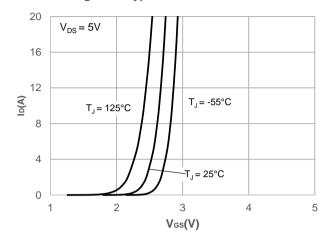


Figure 7: On-resistance vs. Drain Current

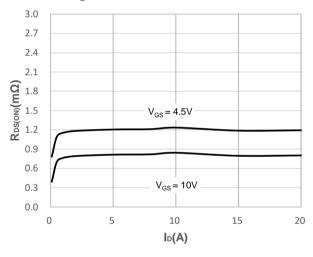


Figure 8: Body Diode Characteristics

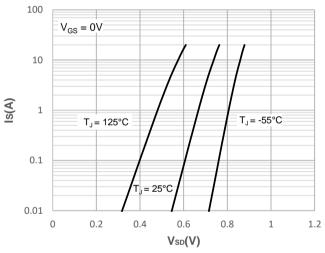


Figure 9: Gate Charge Characteristics

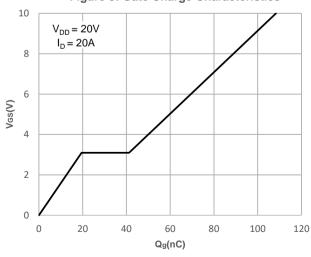
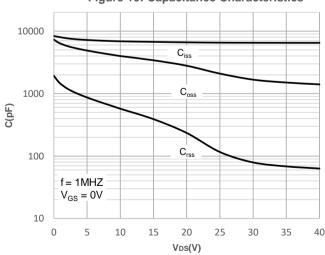


Figure 10: Capacitance Characteristics





# **Typical Performance Characteristics**

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

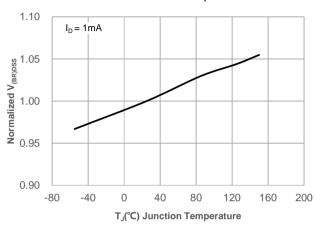


Figure 13: Normalized Threshold Voltage vs.
Junction Temperature

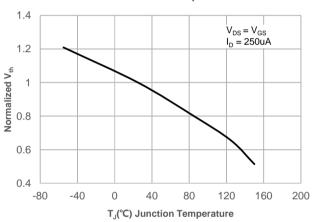


Figure 15: Maximum Safe Operating Area

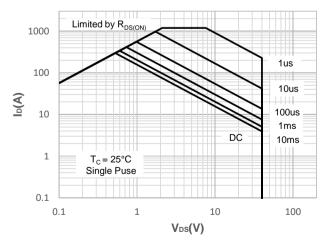
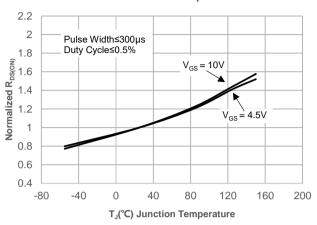
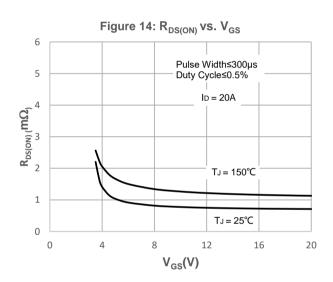


Figure 12: Normalized on Resistance vs.
Junction Temperature







## **Test Circuit**

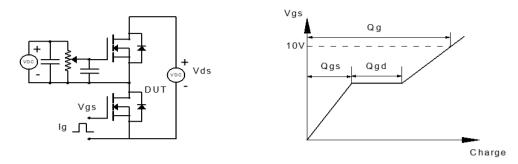


Figure 1: Gate Charge Test Circuit & Waveform

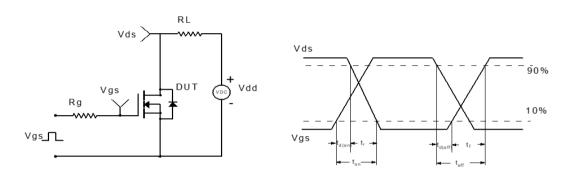


Figure 2: Resistive Switching Test Circuit & Waveform

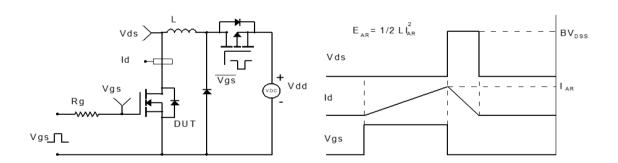


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

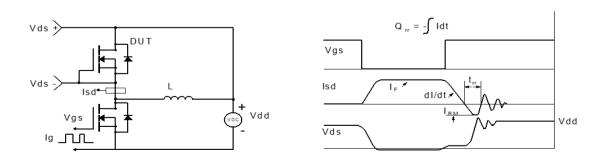
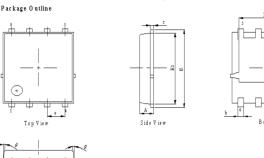


Figure 4: Diode Recovery Test Circuit & Waveform



## Package Mechanical Data(PDFN5x6-8L)



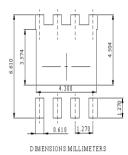
D1
D1
Front View

NOTE

Dimension and tolerance per ASME Y 14.5M, 1994.
 All dimensions in millimeter (angle in degree).
 Dimensions D1 and E1 do not include mold flash protrusions or gate

	MILLIMETER			
DIM.	MIN.	NOM.	MAX.	
A	0.9	1	1.15	
b	0.31	0.41	0.51	
C	0. 24	0.32	0.4	
D	5	5. 2	5. 4	
<b>D</b> 1	4. 95	5. 05	5. 15	
D2	4	4.1	4.2	
E	6.05	6. 15	6. 25	
E1	5. 5	5. 6	5. 7	
E2	3. 42	3, 53	3. 63	
е		1. 27BSC		
Н	0.6	0.7	0.8	
L	0.5	0.7	0.8	
K		1.23 REF		
0			10	

Recommended Soldering Footprint



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